

<b>Notice of References Cited</b>	Application/Control No. 10/005,858	Applicant(s)/Patent Under Reexamination ALLEN, KEITH D.	
	Examiner Celine X. Qian Ph.D.	Art Unit 1636	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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	U	Scarff et al., 2003, Genesis, Vol. 36, page 149-157
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